

DALLAS

SEMICONDUCTOR

DS2251T

128K Soft Microcontroller Module

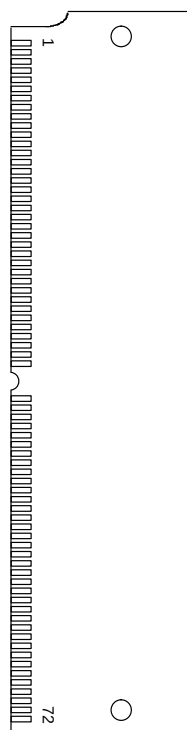
FEATURES

- 8051 compatible microcontroller adapts to its task
 - 32K, 64K, or 128K bytes of nonvolatile SRAM for program and/or data storage
 - In-system programming via on-chip serial port
 - Capable of modifying its own program or data memory in the end system
 - Provides separate Byte-wide bus for peripherals
 - Performs CRC-16 check of NVRAM memory
- High-reliability Operation
 - Maintains all nonvolatile resources for over 10 years in the absence of power
 - Power-fail reset
 - Early Warning Power-fail Interrupt
 - Watchdog Timer
 - Lithium backed memory remembers system state
 - Precision reference for power monitor
- Fully 8051 Compatible
 - 128 bytes scratchpad RAM
 - Two timer/counters
 - On-chip serial port
 - 32 parallel I/O port pins
- Permanently powered real time clock

DESCRIPTION

The DS2251T is an 8051 compatible microcontroller module based on nonvolatile RAM technology. It is designed for systems that need large quantities of non-volatile memory. Like other members of the Secure Microcontroller family, it provides full compatibility with the 8051 instruction set, timers, serial port, and parallel I/O ports. By using NVRAM instead of ROM, the user can program, then reprogram the microcontroller while in-system. The application software can even change its own operation. This allows frequent software upgrades, adaptive programs, customized systems, etc. In addition, by using NVRAM, the DS2251T is ideal

PACKAGE OUTLINE



72-PIN SIMM

for data logging applications. The powerful real time clock includes interrupts for time stamp and date. It keeps time to one hundredth of second using its on-board 32 KHz crystal.

The DS2251T provides the benefits of NVRAM without using I/O resources. Between 32K bytes and 128K bytes of on-board NVRAM are available. A non-multiplexed Byte-wide address and data bus is used for memory access. This bus, which is available at the connector, can perform all memory access and also provides decoded chip enables for off-board memory

mapped peripherals. This leaves the 32 I/O port pins free for application use.

The DS2251T provides high-reliability operation in portable systems or systems with unreliable power. These features include the ability to save the operating state, Power-fail Reset, Power-fail Interrupt, and Watchdog Timer. All nonvolatile memory and resources are maintained for over 10 years at room temperature in the absence of power.

A user loads programs into the DS2251T via its on-chip Serial Bootstrap Loader. This function supervises the

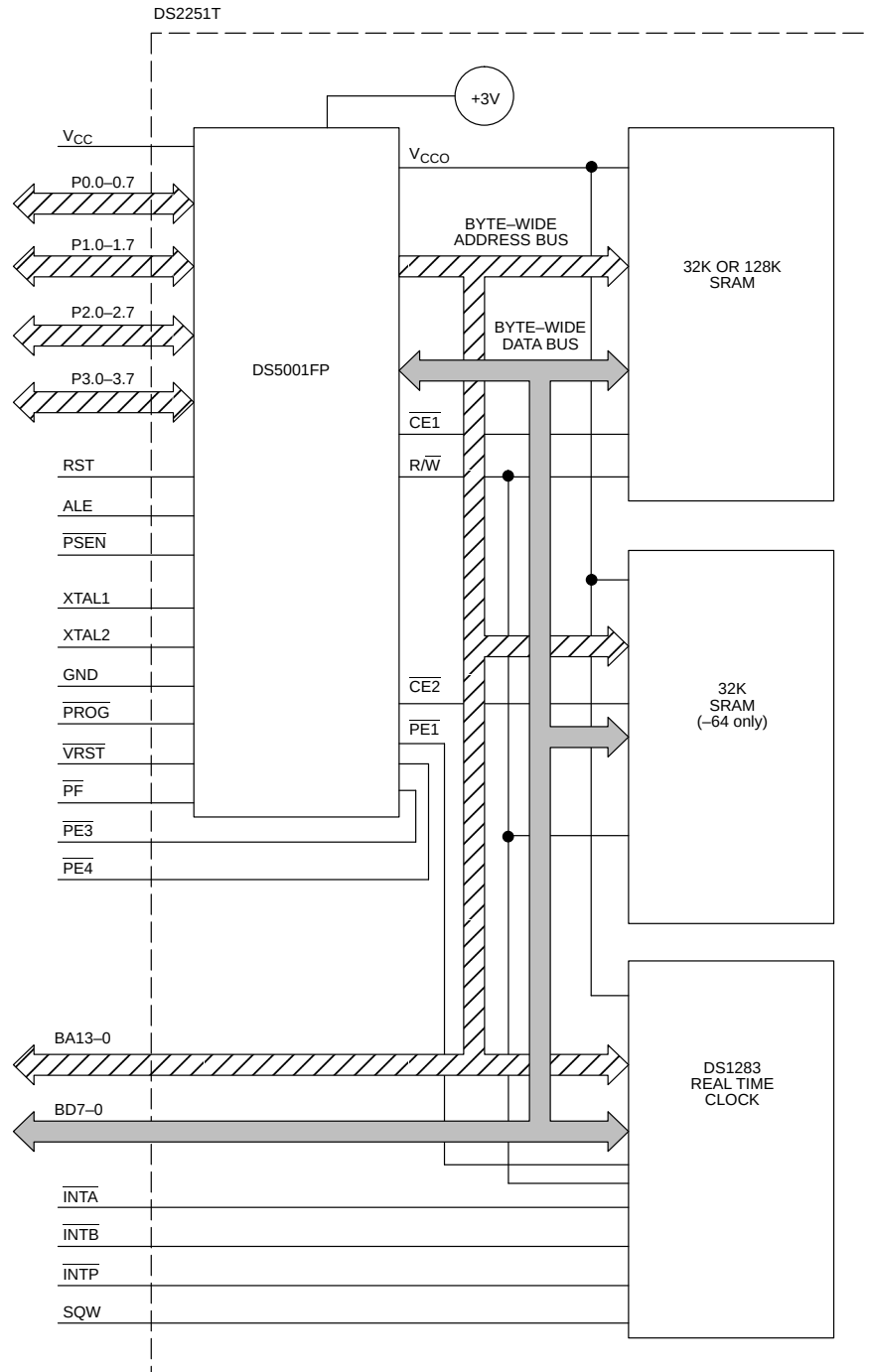
loading of software into NVRAM, validates it, then becomes transparent to the user. Software is stored in on-board CMOS SRAM. Using its internal Partitioning, the DS2251T can divide a common RAM into user selectable program and data segments. This Partition can be selected at program loading time, but can be modified anytime later. The microprocessor will decode memory access to the SRAM, access memory via its Byte-wide bus and write-protect the memory portion designated as program (ROM).

ORDERING INFORMATION

PART NUMBER	RAM SIZE	MAX CRYSTAL SPEED	TIMEKEEPING?
DS2251T-32-16	32K bytes	16 MHz	Yes
DS2251T-64-16	64K bytes	16 MHz	Yes
DS2251T-128-16	128K bytes	16 MHz	Yes

Operating information is contained in the User's Guide section of the Secure Microcontroller Data Book. This data sheet provides ordering information, pinout, and electrical specifications.

DS2251T BLOCK DIAGRAM Figure 1



PIN ASSIGNMENT

1	P1.0	19	XTAL2	37	P0.2	55	$\overline{\text{INTB}}$
2	P1.1	20	GND	38	P0.1	56	BD0
3	P1.2	21	P2.0	39	P0.0	57	BD1
4	P1.3	22	P2.1	40	V _{CC}	58	BD2
5	P1.4	23	P2.2	41	BA0	59	BD3
6	P1.5	24	P2.3	42	BA1	60	BD4
7	P1.6	25	P2.4	43	BA2	61	BD5
8	P1.7	26	P2.5	44	BA3	62	BD6
9	RST	27	P2.6	45	BA4	63	BD7
10	P3.0 RXD	28	P2.7	46	BA5	64	R/W
11	P3.1 TXD	29	$\overline{\text{PSEN}}$	47	BA6	65	$\overline{\text{PF}}$
12	P3.2 $\overline{\text{INT0}}$	30	ALE	48	BA7	66	$\overline{\text{PE3}}$
13	P3.3 $\overline{\text{INT1}}$	31	$\overline{\text{PROG}}$	49	BA8	67	$\overline{\text{PE4}}$
14	P3.4 T0	32	P0.7	50	BA9	68	$\overline{\text{INTP}}$
15	P3.5 T1	33	P0.6	51	BA10	69	$\overline{\text{INTA}}$
16	P3.6 $\overline{\text{WR}}$	34	P0.5	52	BA11	70	SQW
17	P3.7 $\overline{\text{RD}}$	35	P0.4	53	BA12	71	$\overline{\text{VRST}}$
18	XTAL1	36	P0.3	54	BA13	72	BA15

PIN DESCRIPTION

PIN	DESCRIPTION
39–32	P0.0 – P0.7. General purpose I/O Port 0. This port is open–drain and can not drive a logic 1. It requires external pull–ups. Port 0 is also the multiplexed Expanded Address/Data bus. When used in this mode, it does not require pull–ups.
1–8	P1.0 – P1.7. General purpose I/O Port 1.
21–28	P2.0 – P2.7. General purpose I/O Port 2. Also serves as the MSB of the Expanded Address bus.
10	P3.0 RXD. General purpose I/O port pin 3.0. Also serves as the receive signal for the on board UART. This pin should <u>NOT</u> be connected directly to a PC COM port.
11	P3.1 TXD. General purpose I/O port pin 3.1. Also serves as the transmit signal for the on board UART. This pin should <u>NOT</u> be connected directly to a PC COM port.
12	P3.2 $\overline{\text{INT0}}$. General purpose I/O port pin 3.2. Also serves as the active low External Interrupt 0.
13	P3.3 $\overline{\text{INT1}}$. General purpose I/O port pin 3.3. Also serves as the active low External Interrupt 1.
14	P3.4 T0. General purpose I/O port pin 3.4. Also serves as the Timer 0 input.
15	P3.5 T1. General purpose I/O port pin 3.5. Also serves as the Timer 1 input.
16	P3.6 $\overline{\text{WR}}$. General purpose I/O port pin. Also serves as the write strobe for Expanded bus operation.
17	P3.7 $\overline{\text{RD}}$. General purpose I/O port pin. Also serves as the read strobe for Expanded bus operation.

PIN	DESCRIPTION
9	RST – Active high reset input. A logic 1 applied to this pin will activate a reset state. This pin is pulled down internally, can be left unconnected if not used. An RC power-on reset circuit is not needed and is <u>NOT</u> recommended.
29	PSEN – Program Store Enable. This active low signal is used to enable an external program memory when using the Expanded bus. It is normally an output and should be unconnected if not used.
30	ALE – Address Latch Enable. Used to de-multiplex the multiplexed Expanded Address/Data bus on Port 0. This pin is normally connected to the clock input on a '373 type transparent latch.
19, 18	XTAL2, XTAL1 . Used to connect an external crystal to the internal oscillator. XTAL1 is the input to an inverting amplifier and XTAL2 is the output.
20	GND – Logic ground.
40	V_{CC} – +5V.
72	BA15 – Monitor test point to reflect the logical value of A15. Not needed for memory access.
54–41	BA13 – 0 . Byte-wide Address bus bits 13–0. This bus is combined with the non-multiplexed data bus (BD7–0) to access on-board NVSRAM and off-board peripherals. Peripheral decoding is performed using PE3 and PE4. These are on 16K boundaries, so BA14 or BA15 are not needed. Read/write access is controlled by R/W. BA13–0 connect directly to memory mapped peripherals.
63–56	BD7 – 0 . Byte-wide Data bus bits 7–0. This 8 bit bi-directional bus is combined with the non-multiplexed address bus (BA14–0) to access on-board NVSRAM and off-board peripherals.
64	R/W – Read/Write. This signal provides the write enable to the SRAMs on the Byte-wide bus. It is controlled by the memory map and Partition. The blocks selected as Program (ROM) will be write protected. This signal is also used for the write enable to off-board peripherals.
66	PE3 – Peripheral Enable 3. Accesses data memory between addresses 8000h and BFFFh when the PES bit is set to a logic 1. PE3 is not lithium backed and can be connected to any type of peripheral function.
67	PE4 – Peripheral Enable 4. Accesses data memory between addresses C000h and FFFFh when the PES bit is set to a logic 1. PE4 is not lithium backed and can be connected to any type of peripheral function.
31	PROG – Invokes the Bootstrap loader on a falling edge. This signal should be debounced so that only one edge is detected. If connected to ground, the micro will enter Bootstrap loading on power up. This signal is pulled up internally.
71	VRST – This I/O pin indicates that the power supply (V _{CC}) has fallen below the V _{CCMIN} level and the micro is in a reset state. When this occurs, the DS2251T will drive this pin to a logic 0. Because the micro is lithium backed, this signal is guaranteed even when V _{CC} =0V. Because it is an I/O pin, it will also force a reset if pulled low externally. This allows multiple parts to synchronize their power-down resets.
65	PF – This output goes to a logic 0 to indicate that the micro has switched to lithium backup. It corresponds to V _{CC} < V _{LI} . Because the micro is lithium backed, this signal is guaranteed even when V _{CC} =0V.
55	INTB – INTB from the real time clock. This output may be connected to a micro interrupt input.

PIN	DESCRIPTION
68	INTP – $\overline{\text{INTP}}$ from the real time clock. This open-drain output requires a pull-up and may be connected to a micro interrupt input.
69	INTA – $\overline{\text{INTA}}$ from the real time clock. This output may be connected to a micro interrupt input.
70	SQW – SQW output from the DS1283 Real Time Clock. Can be programmed to output an 1024 Hz square wave.

INSTRUCTION SET

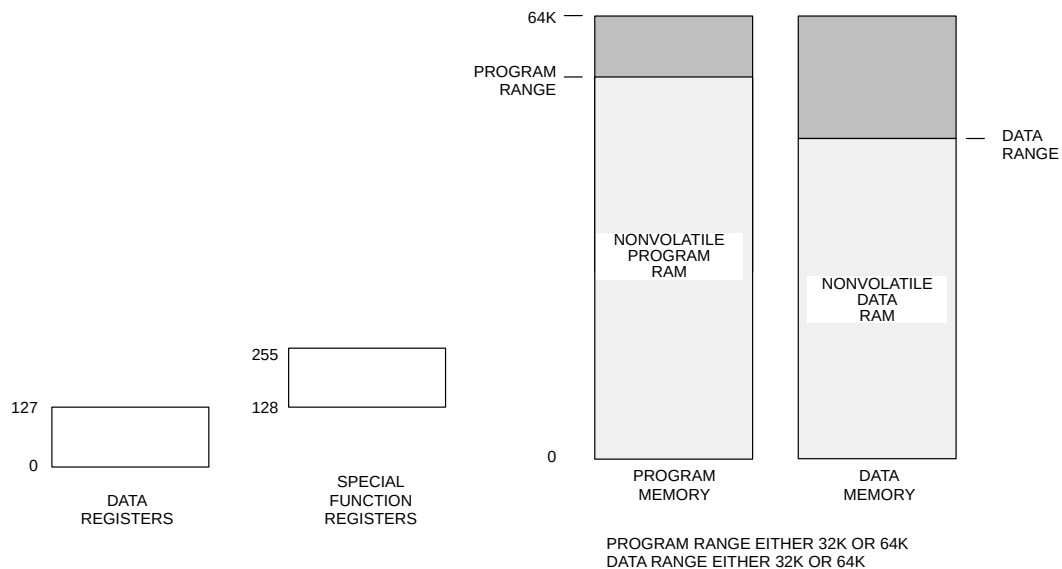
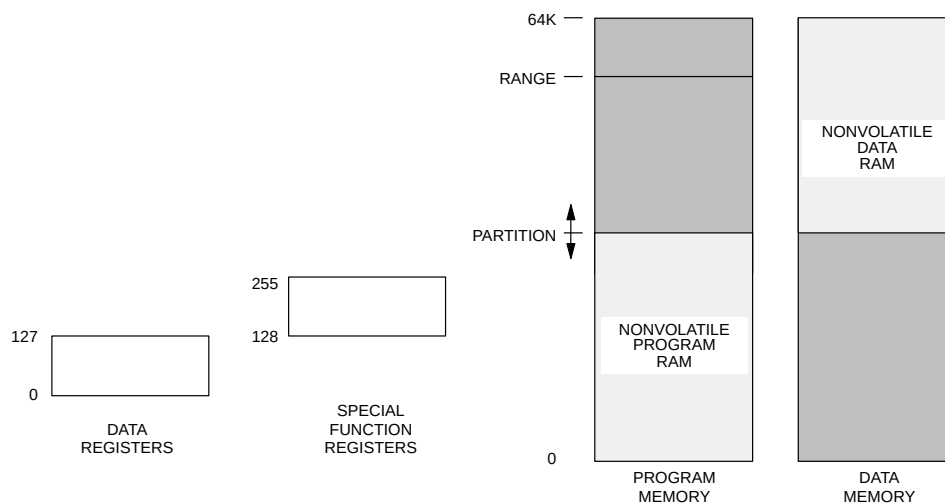
The DS2251T executes an instruction set that is object code compatible with the industry standard 8051 microcontroller. As a result, software development packages such as assemblers and compilers that have been written for the 8051 are compatible with the DS2251T.

A complete description of the instruction set and operation are provided in the User's Guide section of the Secure Microcontroller Data Book.

MEMORY ORGANIZATION

Figure 2 illustrates the memory map accessed by the DS2251T. The entire 64K of program and 64K of data

are available to the Byte-wide bus. This preserves the I/O ports for application use. The user controls the portion of memory that is actually mapped to the Byte-wide bus by selecting the Program Range and Data Range. Any area not mapped into the NVRAM is reached via the Expanded bus on Ports 0 and 2. An alternate configuration allows dynamic Partitioning of a 64K space as shown in Figure 3. Selecting PES=1 provides access to the real time clock on the DS2251T and enables $\overline{\text{PE3}}$ and $\overline{\text{PE4}}$ for peripheral access as shown in Figure 4. These selections are made using Special Function Registers. The memory map and its controls are covered in detail in the User's Guide section of the Secure Microcontroller Data Book.

DS2251T MEMORY MAP IN NON-PARTITIONABLE MODE (PM=1) Figure 2**DS2251T MEMORY MAP IN PARTITIONABLE MODE (PM=0) Figure 3**

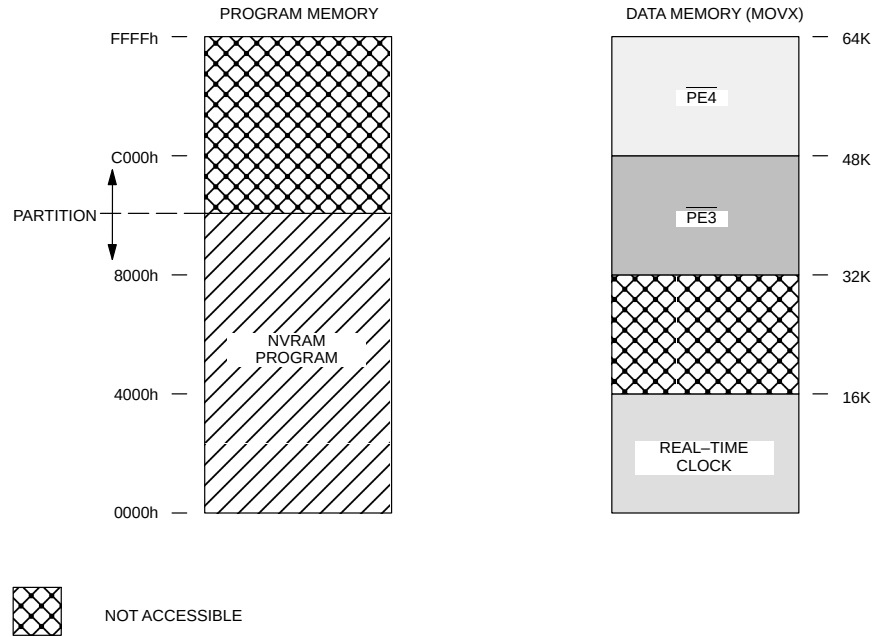
NOTE: PARTIONABLE MODE IS NOT SUPPORTED IN 128KB MODE.

LEGEND:

 = ON-CHIP REGISTERS

 = ACCESSED VIA BYTEWISE BUS

 = ACCESSED VIA EXPANDED BUS (PORTS 0 AND 2)

DS2251T MEMORY MAP WITH (PES=1) Figure 4**POWER MANAGEMENT**

The DS2251T monitors V_{CC} to provide Power-fail Reset, early warning Power-fail Interrupt, and switch over to lithium backup. It uses an internal band-gap reference in determining the switch points. These are called V_{PFW} , V_{CCMIN} , and V_{LI} respectively. When V_{CC} drops below V_{PFW} , the DS2251T will perform an interrupt vector to location 2Bh if the power fail warning was enabled. Full processor operation continues regardless. When power falls further to V_{CCMIN} , the DS2251T invokes a reset state. No further code execution will be

performed unless power rises back above V_{CCMIN} . All decoded chip enables and the $R/\overline{W}$ signal go to an inactive (logic 1) state. The $\overline{VRST}$ signal will be driven to a logic 0. V_{CC} is still the power source at this time. When V_{CC} drops further to below V_{LI} , internal circuitry will switch to the built-in lithium cell for power. The majority of internal circuits will be disabled and the remaining nonvolatile states will be retained. $\overline{PF}$ will be driven to a logic 0. The User's Guide has more information on this topic. The trip points V_{CCMIN} and V_{PFW} are listed in the electrical specifications.

ABSOLUTE MAXIMUM RATINGS*

Voltage on Any Pin Relative to Ground	–0.3V to +7.0V
Operating Temperature	0°C to 70°C
Storage Temperature	–40°C to +70°C
Soldering Temperature	260°C for 10 seconds

* This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operation sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods of time may affect reliability.

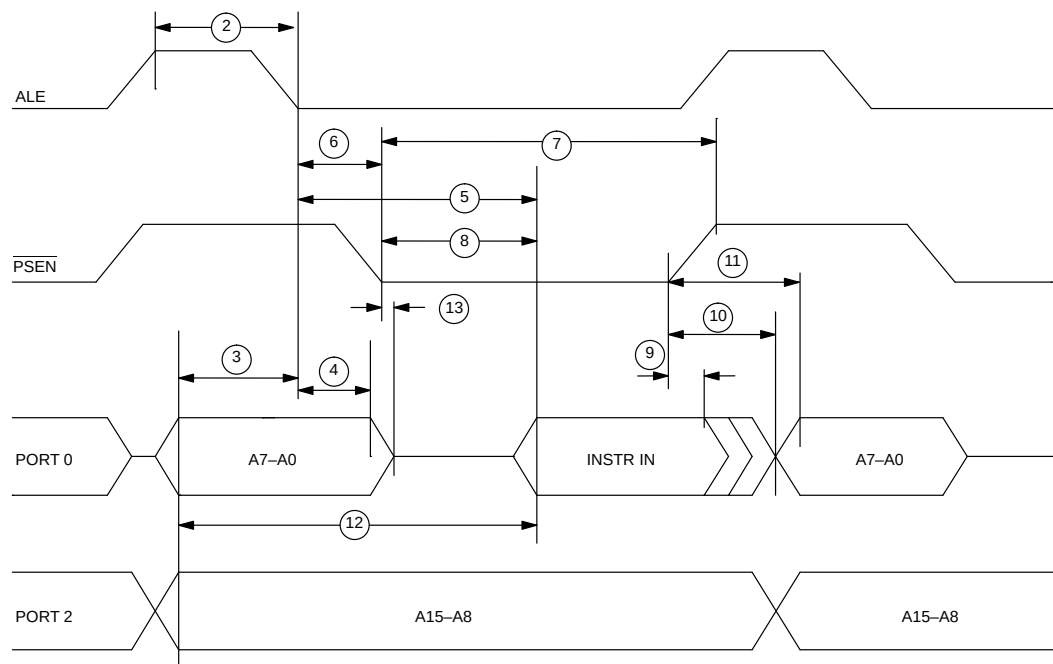
DC CHARACTERISTICS(t_A = 0°C to 70°C; V_{CC} = 5V ± 10%)

PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	NOTES
Input Low Voltage	V _{IL}	–0.3		+0.8	V	1
Input High Voltage	V _{IH1}	2.0		V _{CC} + 0.3	V	1
Input High Voltage RST, XTAL1 PROG	V _{IH2}	3.5		V _{CC} + 0.3	V	1
Output Low Voltage @ I _{OL} = 1.6 mA (Ports 1, 2, 3)	V _{OL1}		0.15	0.45	V	1
Output Low Voltage @ I _{OL} = 3.2 mA (Ports 0, ALE, PSEN, PF, BA13–0, BD7–0, R/W, PE3–4)	V _{OL2}		0.15	0.45	V	1
Output High Voltage @ I _{OH} = –80 μA (Ports 1, 2, 3)	V _{OH1}	2.4	4.8		V	1
Output High Voltage @ I _{OH} = –400 μA (Ports 0, ALE, PSEN, PF, BA13–0, BD7–0, R/W, PE3–4)	V _{OH2}	2.4	4.8		V	1
Input Low Current V _{IN} = 0.45V (Ports 1, 2, 3)	I _{IL}			–50	μA	
Transition Current; 1 to 0 V _{IN} = 2.0V (Ports 1, 2, 3)	I _{TL}			–500	μA	
Input Leakage Current 0.45 < V _{IN} < V _{CC} (Port 0)	I _{IL}			±10	μA	
RST Pulldown Resistor	R _{RE}	40		150	KΩ	
VRST Pullup Resistor	R _{VR}		4.7		KΩ	
PROG Pullup Resistor	R _{PR}		40		KΩ	
Power Fail Warning Voltage	V _{PFW}	4.25	4.37	4.50	V	1
Minimum Operating Voltage	V _{CCmin}	4.00	4.12	4.25	V	1
Operating Current @ 16 MHz	I _{CC}			45	mA	2
Idle Mode Current @ 12 MHz	I _{IDLE}			7.0	mA	3
Stop Mode Current	I _{STOP}			80	μA	4
Pin Capacitance	C _{IN}			10	pF	5
Reset Trip Point in Stop Mode w/BAT=3.0V w/BAT=3.3V		4.0 4.4		4.25 4.65	V	1

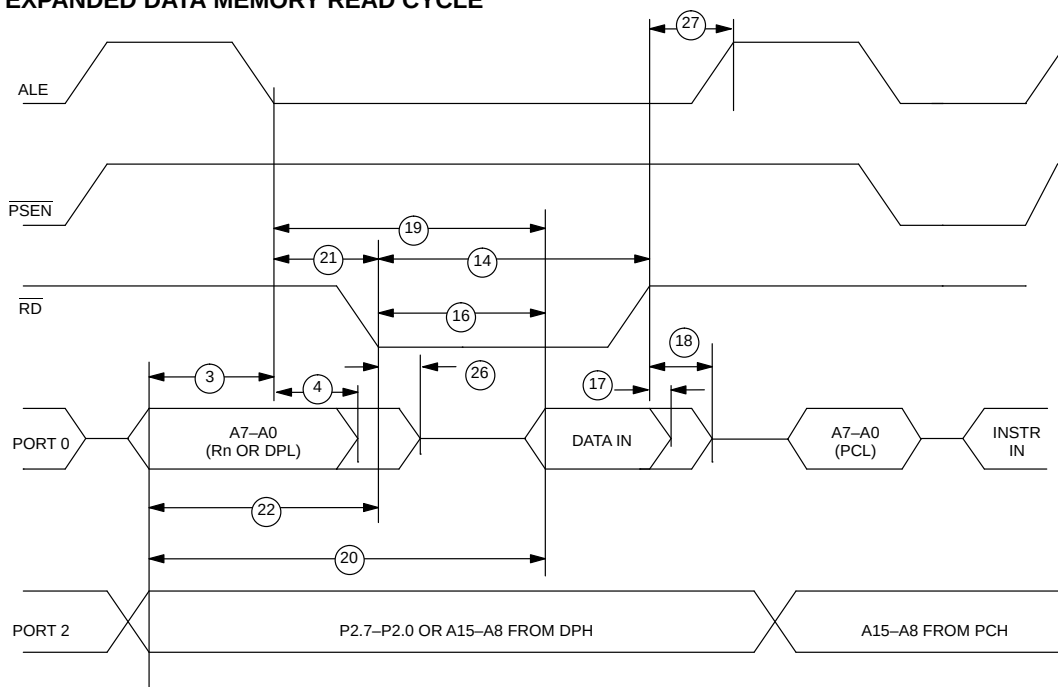
AC CHARACTERISTICS**EXPANDED BUS MODE TIMING SPECIFICATIONS**(t_A = 0°C to 70°C; V_{CC} = 5V ± 10%)

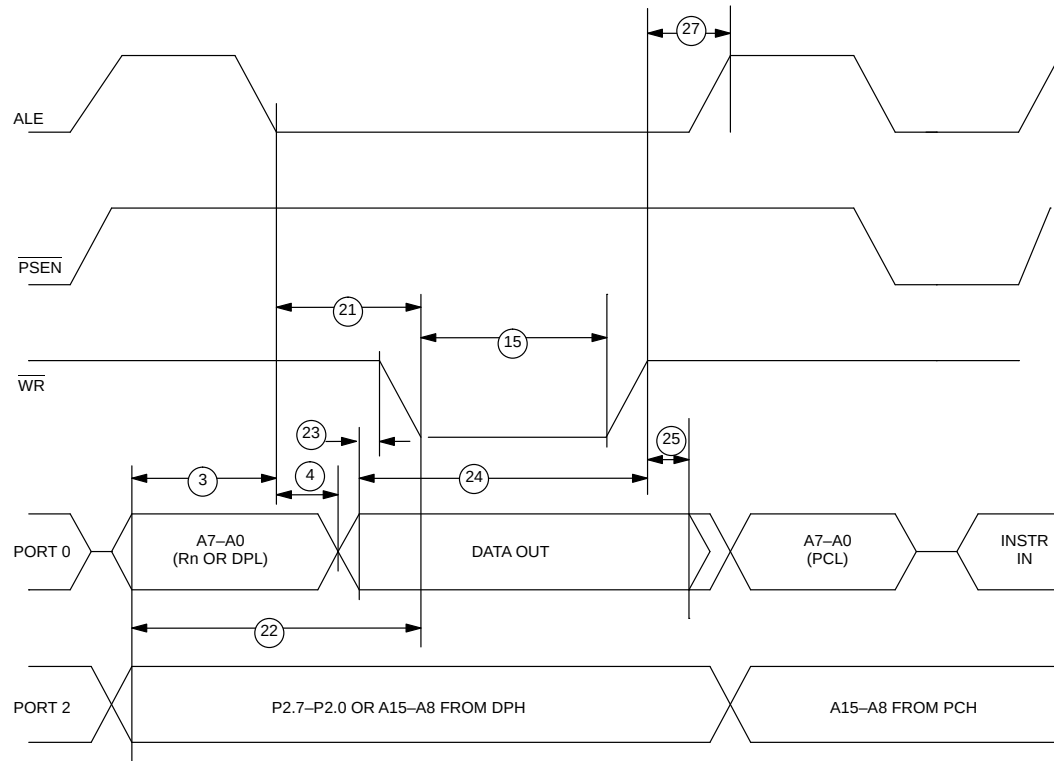
#	PARAMETER	SYMBOL	MIN	MAX	UNITS
1	Oscillator Frequency	1/t _{CLK}	1.0	16 (-16)	MHz
2	ALE Pulse Width	t _{ALPW}	2t _{CLK} -40		ns
3	Address Valid to ALE Low	t _{AVALL}	t _{CLK} -40		ns
4	Address Hold After ALE Low	t _{AVAAV}	t _{CLK} -35		ns
5	ALE Low to Valid Instr. In @12 MHz @16 MHz	t _{ALLVI}		4t _{CLK} -150 4t _{CLK} -90	ns
6	ALE Low to $\overline{\text{PSEN}}$ Low	t _{ALLPSL}	t _{CLK} -25		ns
7	$\overline{\text{PSEN}}$ Pulse Width	t _{PSPW}	3t _{CLK} -35		ns
8	$\overline{\text{PSEN}}$ Low to Valid Instr. In @12 MHz @16 MHz	t _{PSLVI}		3t _{CLK} -150 3t _{CLK} -90	ns ns
9	Input Instr. Hold after $\overline{\text{PSEN}}$ Going High	t _{PSIV}	0		ns
10	Input Instr. Float after $\overline{\text{PSEN}}$ Going High	t _{PSIX}		t _{CLK} -20	ns
11	Address Hold after $\overline{\text{PSEN}}$ Going High	t _{PSAV}	t _{CLK} -8		ns
12	Address Valid to Valid Instr. In @12 MHz @16 MHz	t _{AVVI}		5t _{CLK} -150 5t _{CLK} -90	ns ns
13	$\overline{\text{PSEN}}$ Low to Address Float	t _{PSLAZ}	0		ns
14	$\overline{\text{RD}}$ Pulse Width	t _{RDPW}	6t _{CLK} -100		ns
15	$\overline{\text{WR}}$ Pulse Width	t _{WRPW}	6t _{CLK} -100		ns
16	$\overline{\text{RD}}$ Low to Valid Data In @12 MHz @16 MHz	t _{RDLDV}		5t _{CLK} -165 5t _{CLK} -105	ns ns
17	Data Hold after $\overline{\text{RD}}$ High	t _{RDHDV}	0		ns
18	Data Float after $\overline{\text{RD}}$ High	t _{RDHDZ}		2t _{CLK} -70	ns
19	ALE Low to Valid Data In @12 MHz @16 MHz	t _{ALLVD}		8t _{CLK} -150 8t _{CLK} -90	ns ns
20	Valid Addr. to Valid Data In @12 MHz @16 MHz	t _{AVDV}		9t _{CLK} -165 9t _{CLK} -105	ns ns
21	ALE Low to $\overline{\text{RD}}$ or $\overline{\text{WR}}$ Low	t _{ALLRDL}	3t _{CLK} -50	3t _{CLK} +50	ns
22	Address Valid to $\overline{\text{RD}}$ or $\overline{\text{WR}}$ Low	t _{AVRDL}	4t _{CLK} -130		ns
23	Data Valid to $\overline{\text{WR}}$ Going Low	t _{DVWRL}	t _{CLK} -60		ns
24	Data Valid to $\overline{\text{WR}}$ High @12 MHz @16 MHz	t _{DVWRH}	7t _{CLK} -150 7t _{CLK} -90		ns ns
25	Data Valid after $\overline{\text{WR}}$ High	t _{WRHDV}	t _{CLK} -50		ns
26	$\overline{\text{RD}}$ Low to Address Float	t _{RDLAZ}		0	ns
27	$\overline{\text{RD}}$ or $\overline{\text{WR}}$ High to ALE High	t _{RDHALH}	t _{CLK} -40	t _{CLK} +50	ns

EXPANDED PROGRAM MEMORY READ CYCLE



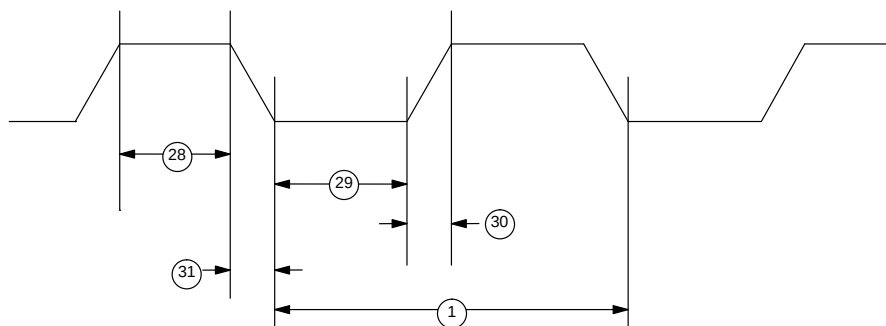
EXPANDED DATA MEMORY READ CYCLE



EXPANDED DATA MEMORY WRITE CYCLE**AC CHARACTERISTICS (cont'd)****EXTERNAL CLOCK DRIVE**(t_A = 0°C to 70°C; V_{CC} = 5V ± 10%)

#	PARAMETER	SYMBOL	MIN	MAX	UNITS
28	External Clock High Time @12 MHz @16 MHz	t _{CLKHPW}	20 15		ns ns
29	External Clock Low Time @12 MHz @16 MHz	t _{CLKLPW}	20 15		ns ns
30	External Clock Rise Time @12 MHz @16 MHz	t _{CLKR}		20 15	ns ns
31	External Clock Fall Time @12 MHz @16 MHz	t _{CLKF}		20 15	ns ns

EXTERNAL CLOCK TIMING



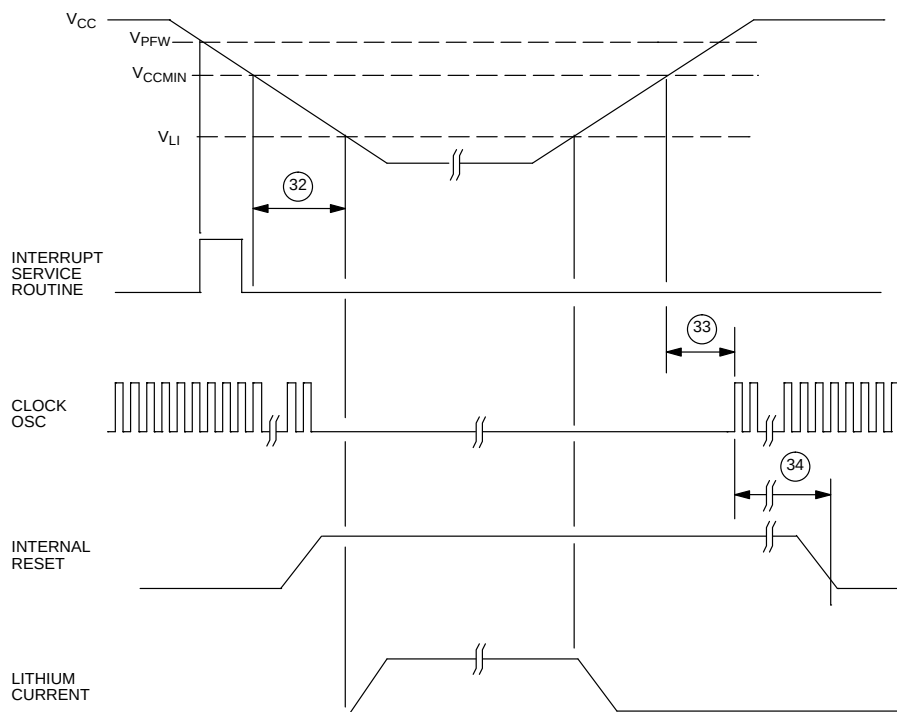
AC CHARACTERISTICS (cont'd)

POWER CYCLING TIMING

(t_A = 0°C to 70°C; V_{CC} = 5V ± 10%)

#	PARAMETER	SYMBOL	MIN	MAX	UNITS
32	Slew Rate from V _{CCMIN} to V _{LI}	t _F	130		μs
33	Crystal Start up Time	t _{CSU}		(note 6)	
34	Power On Reset Delay	t _{POR}		21504	t _{CLK}

POWER CYCLE TIMING



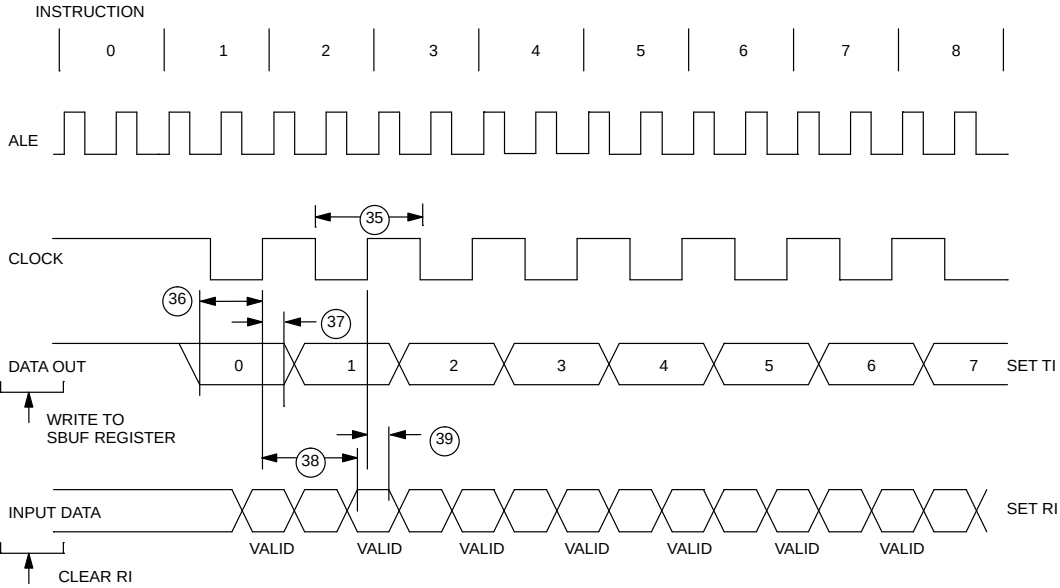
AC CHARACTERISTICS (cont'd)

SERIAL PORT TIMING – MODE 0

(t_A = 0°C to70°C; V_{CC} = 5V ± 10%)

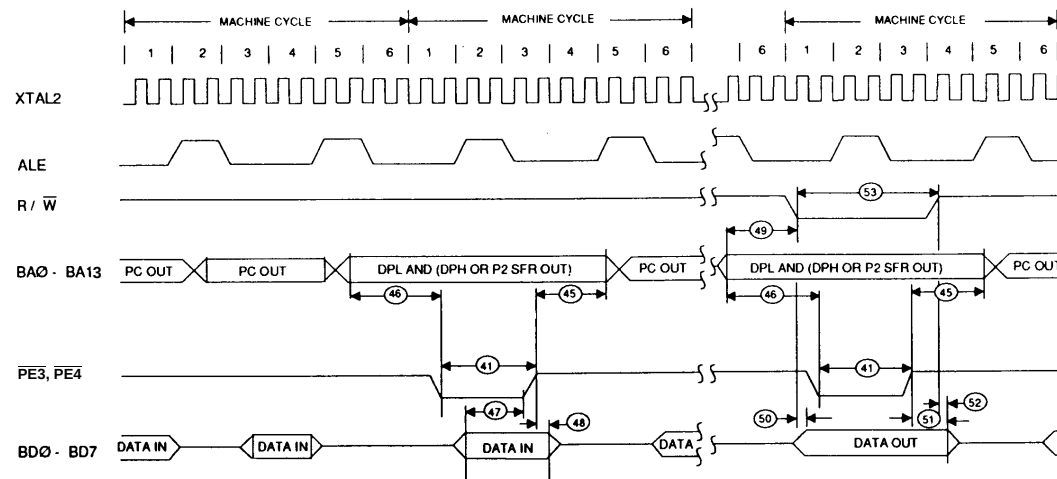
#	PARAMETER	SYMBOL	MIN	MAX	UNITS
35	Serial Port Clock Cycle Time	t _{SPCLK}	12t _{CLK}		μs
36	Output Data Setup to Rising Clock Edge	t _{DOCH}	10t _{CLK} –133		ns
37	Output Data Hold after Rising Clock Edge	t _{CHDO}	2t _{CLK} –117		ns
38	Clock Rising Edge to Input Data Valid	t _{CHDV}		10t _{CLK} –133	ns
39	Input Data Hold after Rising Clock Edge	t _{CHDIV}	0		ns

SERIAL PORT TIMING – MODE 0



AC CHARACTERISTICS (cont'd)**PARALLEL PROGRAM LOAD TIMING** $(t_A = 0^\circ\text{C to } 70^\circ\text{C}; V_{CC} = 5\text{V} \pm 10\%)$

#	PARAMETER	SYMBOL	MIN	MAX	UNITS
41	Pulse Width of $\overline{\text{PE}}3\text{--}4$	t_{CEPW}	$4t_{\text{CLK}}\text{--}35$		ns
45	Byte-wide Address Hold after $\overline{\text{PE}}3\text{--}4$ High During MOVX	t_{CEHDA}	$4t_{\text{CLK}}\text{--}30$		ns
46	Delay from Byte-wide Address Valid $\overline{\text{PE}}3\text{--}4$ Low During MOVX	t_{CELDA}	$4t_{\text{CLK}}\text{--}35$		ns
47	Byte-wide Data Setup to $\overline{\text{PE}}3\text{--}4$ High During MOVX (read)	t_{DACEH}	$1t_{\text{CLK}}\text{+}40$		ns
48	Byte-wide Data Hold after $\overline{\text{PE}}3\text{--}4$ High During MOVX (read)	t_{CEHDV}	10		ns
49	Byte-wide Address Valid to $\text{R}/\overline{\text{W}}$ Active During MOVX (write)	t_{AVRWL}	$3t_{\text{CLK}}\text{--}35$		ns
50	Delay from $\text{R}/\overline{\text{W}}$ Low to Valid Data Out During MOVX (write)	t_{RWLDV}	20		ns
51	Valid Data Out Hold Time from $\overline{\text{PE}}3\text{--}4$ High	t_{CEHDV}	$1t_{\text{CLK}}\text{--}15$		ns
52	Valid Data Out Hold Time from $\text{R}/\overline{\text{W}}$ High	t_{RWHDV}	0		ns
53	Write Pulse Width ($\text{R}/\overline{\text{W}}$ Low Time)	t_{RWLPW}	$6t_{\text{CLK}}\text{--}20$		ns

BYTE-WIDE BUS TIMING

RPC AC CHARACTERISTICS – DBB READ $(t_A = 0^{\circ}\text{C to } 70^{\circ}\text{C}; V_{CC} = 5\text{V} \pm 10\%)$

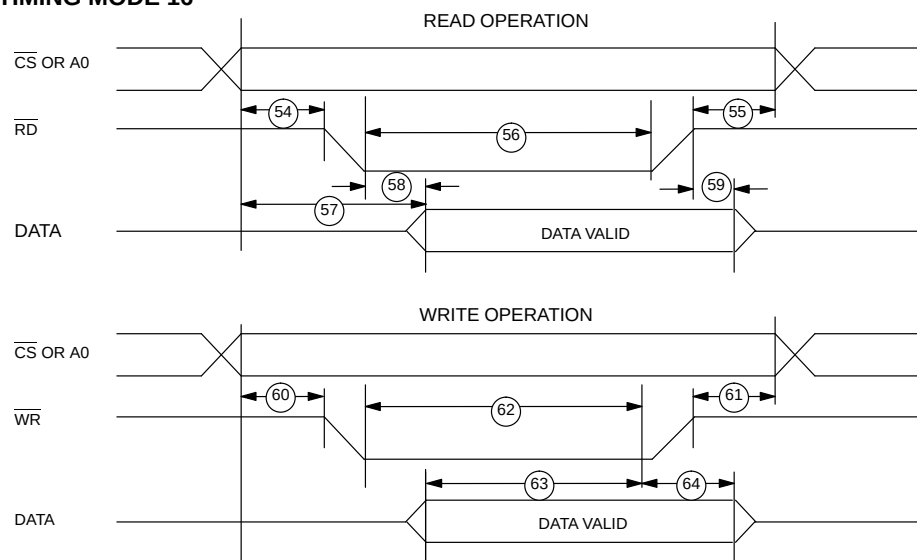
#	PARAMETER	SYMBOL	MIN	MAX	UNITS
54	$\overline{\text{CS}}$, A_0 Setup to $\overline{\text{RD}}$	t_{AR}	0		ns
55	$\overline{\text{CS}}$, A_0 Hold After $\overline{\text{RD}}$	t_{RA}	0		ns
56	$\overline{\text{RD}}$ Pulse Width	t_{RR}	160		ns
57	$\overline{\text{CS}}$, A_0 to Data Out Delay	t_{AD}		130	ns
58	$\overline{\text{RD}}$ to Data Out Delay	t_{RD}	0	130	ns
59	$\overline{\text{RD}}$ to Data Float Delay	t_{RDZ}		85	ns

RPC AC CHARACTERISTICS – DBB WRITE $(t_A = 0^{\circ}\text{C to } 70^{\circ}\text{C}; V_{CC} = 5\text{V} \pm 10\%)$

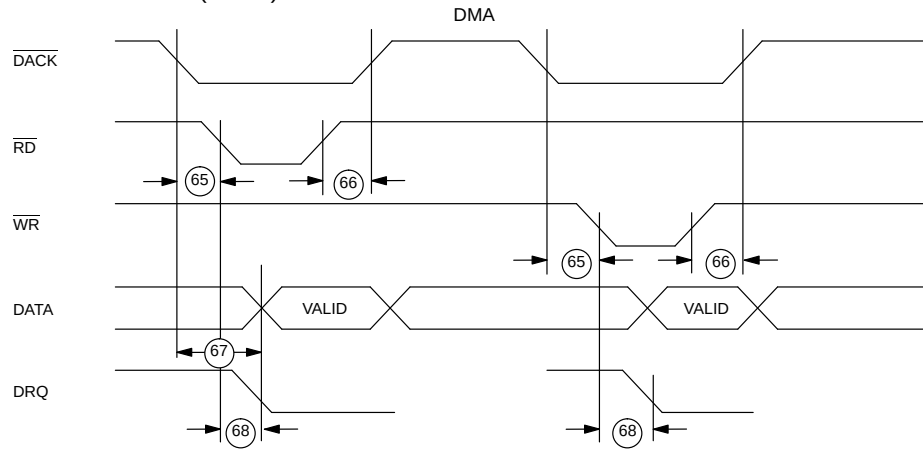
#	PARAMETER	SYMBOL	MIN	MAX	UNITS
60	$\overline{\text{CS}}$, A_0 Setup to $\overline{\text{WR}}$	t_{AW}	0		ns
61A	$\overline{\text{CS}}$, Hold After $\overline{\text{WR}}$	t_{WA}	0		ns
61B	A_0 , Hold After $\overline{\text{WR}}$	t_{WA}	20		ns
62	$\overline{\text{WR}}$ Pulse Width	t_{WW}	20		ns
63	Data Setup to $\overline{\text{WR}}$	t_{DW}	130		ns
64	Data Hold After $\overline{\text{WR}}$	t_{WD}	20		ns

AC CHARACTERISTICS – DMA $(t_A = 0^{\circ}\text{C to } 70^{\circ}\text{C}; V_{CC} = 5\text{V} \pm 10\%)$

#	PARAMETER	SYMBOL	MIN	MAX	UNITS
65	$\overline{\text{DACK}}$ to $\overline{\text{WR}}$ or $\overline{\text{RD}}$	t_{ACC}	0		ns
66	$\overline{\text{RD}}$ or $\overline{\text{WR}}$ to $\overline{\text{DACK}}$	t_{CAC}	0		ns
67	$\overline{\text{DACK}}$ to Data Valid	t_{ACD}	0	130	ns
68	$\overline{\text{RD}}$ or $\overline{\text{WR}}$ to DRQ Cleared	t_{CRQ}		110	ns

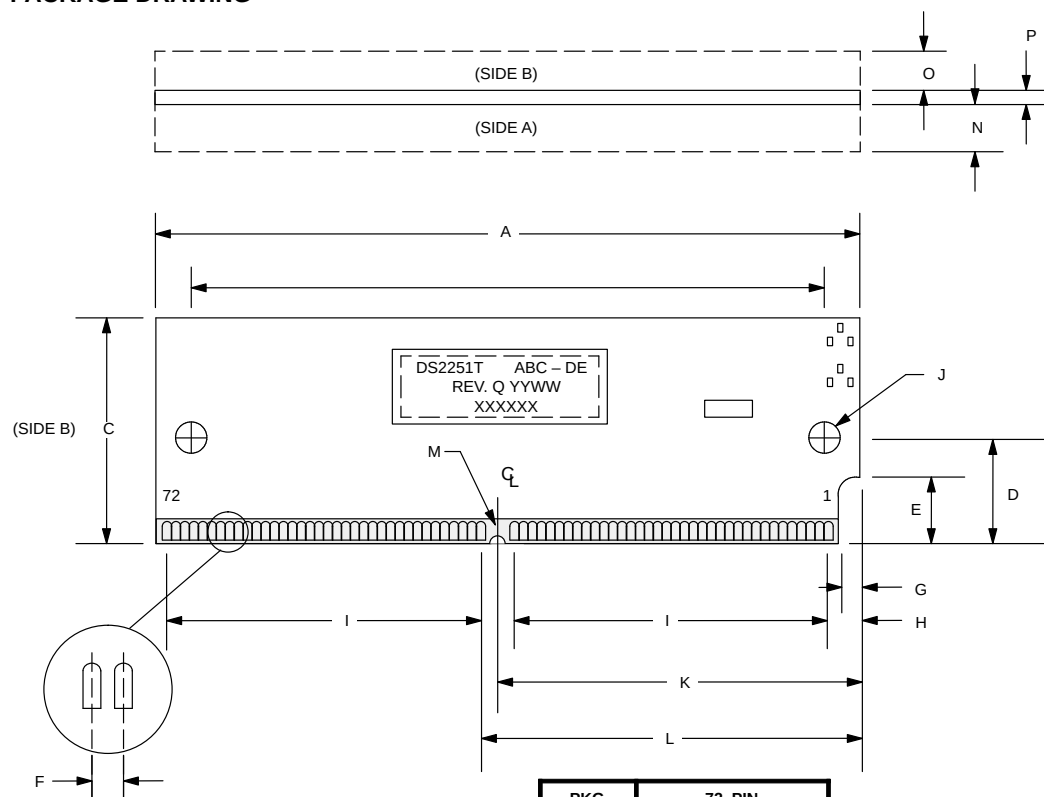
RPC TIMING MODE 16**AC CHARACTERISTICS – $\overline{\text{PROG}}$** $(t_A = 0^\circ\text{C to } 70^\circ\text{C}; V_{CC} = 5\text{V} \pm 10\%)$

#	PARAMETER	SYMBOL	MIN	MAX	UNITS
69	$\overline{\text{PROG}}$ Low to Active	t_{PRA}	48		CLKS
70	$\overline{\text{PROG}}$ High to Inactive	t_{PRI}	48		CLKS

RPC TIMING MODE 16 (cont'd)**NOTES:**

1. All voltages are referenced to ground.
2. Maximum operating I_{CC} is measured with all output pins disconnected; XTAL1 driven with t_{CLKR} , $t_{CLKF}=10$ ns, $V_{IL} = 0.5V$; XTAL2 disconnected; RST = PORT0 = V_{CC} .
3. Idle mode I_{IDLE} is measured with all output pins disconnected; XTAL1 driven with t_{CLKR} , $t_{CLKF} = 10$ ns, $V_{IL} = 0.5V$; XTAL2 disconnected; PORT0 = V_{CC} , RST = V_{SS} .
4. Stop mode I_{STOP} is measured with all output pins disconnected; PORT0 = V_{CC} ; XTAL2 not connected; RST = XTAL1 = V_{SS} .
5. Pin capacitance is measured with a test frequency – 1 MHz, $t_A = 25^{\circ}C$.
6. Crystal start-up time is the time required to get the mass of the crystal into vibrational motion from the time that power is first applied to the circuit until the first clock pulse is produced by the on-chip oscillator. The user should check with the crystal vendor for a worst case specification on this time.

PACKAGE DRAWING



PKG	72-PIN	
DIM	MIN	MAX
A	4.245	4.255
B	3.979	3.989
C	0.995	1.005
D	0.395	0.405
E	0.245	0.255
F	0.050 BSC	
G	0.075	0.085
H	0.245	0.255
I	1.750 BSC	
J	0.120	0.130
K	2.120	2.130
L	2.245	2.255
M	0.057	0.067
N	—	0.275
O	—	0.145
P	—	0.054